DRAFT TANZANIA STANDARD

(Draft for comments only)

Terrestrial photovoltaic (PV) modules - Design qualification and type approval - Part 1-3: Special requirements for testing of thin-film amorphous silicon based photovoltaic (PV)
0 National Foreword

This draft Tanzania Standard has been prepared by the Renewable Energy Technical Committee, under the supervision of the Electrotechnical Divisional Standards Committee (EDC)

This draft Tanzania Standard is an adoption of the International Standard 61215-1-3:2016 Terrestrial photovoltaic (PV) modules - Design qualification and type approval - Part 1-3: Special requirements for testing of thin-film amorphous silicon based photovoltaic (PV) which has been prepared by the International Electrotechnical Commission.

1 Terminology and conventions

Some terminologies and certain conventions are not identical with those used in Tanzania standards; attention is drawn especially to the following:

1) The comma has been used as a decimal marker for metric dimensions. In Tanzania Standards, it is current practice to use “full point” on the baseline as the decimal marker.

2) Where the words “International Standard(s)” appear, referring to this standard they should read “Tanzania Standard(s)”. 
INTERNATIONAL STANDARD

Terrestrial photovoltaic (PV) modules – Design qualification and type approval – Part 1-3: Special requirements for testing of thin-film amorphous silicon based photovoltaic (PV) modules

INTERNATIONALE

Modules photovoltaïques (PV) pour applications terrestres – Qualification de la conception et homologation –

Partie 1-3: Exigences particulières d'essai des modules photovoltaïques (PV) au silicium amorphe à couches minces

INTERNATIONAL

ELECTROTECHNICAL

COMMISSION

ELECTROTECHNIQUE

INTERNATIONALE
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FOREWORD

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8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.

9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61215-1-3 has been prepared by IEC technical committee 82:

Solar photovoltaic energy systems

This edition cancels and replaces the second edition of IEC 61646, issued in 2008, and constitutes a technical revision.

This edition constitutes a technical revision for thin-film a-Si/µc-Si based terrestrial photovoltaic modules.

This standard is to be read in conjunction with IEC 61215-1:2016 and IEC 61215-2:2016.
The text of this standard is based on the following documents:

<table>
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<th>Report on voting</th>
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<td>82/1183/FDIS</td>
<td>82/1207/RVD</td>
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</tbody>
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Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61215 series, published under the general title *Terrestrial photovoltaic (PV) modules – Design qualification and type approval*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under “http://webstore.iec.ch” in the data related to the specific document. At this date, the document will be

- reconformed,
- withdrawn,
- replaced by a revised edition, or
- amended
TERRESTRIAL PHOTOVOLTAIC (PV) MODULES –
DESIGN QUALIFICATION AND TYPE APPROVAL –

Part 1-3: Special requirements for testing of thin-film amorphous silicon based photovoltaic (PV) modules

1 Scope and object

This part of IEC 61215 lays down IEC requirements for the design qualification and type approval of terrestrial photovoltaic modules suitable for long-term operation in general open-air climates, as defined in IEC 60721-2-1. This document is intended to apply to all thin-film amorphous silicon (a-Si; a-Si/µc-Si) based terrestrial flat plate modules. As such, it addresses special requirements for testing of this technology supplementing IEC 61215-1:2016 and IEC 61215-2:2016 requirements for testing.

This document does not apply to modules used with concentrated sunlight although it may be utilized for low concentrator modules (1 to 3 suns). For low concentration modules, all tests are performed using the current, voltage and power levels expected at the design concentration.

The object of this test sequence is to determine the electrical and thermal characteristics of the module and to show, as far as possible within reasonable constraints of cost and time, that the module is capable of withstanding prolonged exposure in climates described in the scope. The actual lifetime expectancy of modules so qualified will depend on their design, their environment and the conditions under which they are operated.

This document defines PV technology dependent modifications to the testing procedures and requirements per IEC 61215-1:2016 and IEC 61215-2:2016.

2 Normative references

The normative references of IEC 61215-1:2016 and IEC 61215-2:2016 are applicable without modifications.

3 Terms and definitions

This clause of IEC 61215-1:2016 is applicable without modifications.

4 Test samples

This clause of IEC 61215-1:2016 is applicable without modifications.

5 Marking and documentation

This clause of IEC 61215-1:2016 is applicable without modifications.

6 Testing

This clause of IEC 61215-1:2016 is applicable with the following modifications: